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Method for photoelectric emission spectrochemical analysis of cadmium metal

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Contents

	1	Page
1	Scope	· 1
2	Normative references · · · · · · · · · · · · · · · · · · ·	· 1
3	Terms and definitions ·····	· 1
4	General · · · · · · · · · · · · · · · · · · ·	· 2
$5 \\ 5.1 \\ 5.2$	Expression of analytical values Number of measurements Expression of analytical values	$\cdot 2$
6	Summary ·····	. 3
7 7.1 7.2	Apparatus Atomic emission spectrophotometer Apparatus and tools for sampling, sample preparation and electrode preparation	.3
8 8.1 8.2 8.3	Samples Analytical portion Samples for calibration curve Samples for correction of calibration curve	· 4 · 4
9 9.1 9.2 9.3 9.4	Preparation of samples General Preparation of analytical portion Preparation of samples for calibration curve Preparation of samples for correction of calibration curve	· 4 · 5 · 6
10	Measurements	$\cdot 7$
11	Preparation of calibration curve ······	. 8
12	Calculation ·····	
Anne	ex A (normative) Atomic emission spectrophotometer	10

Foreword

This Japanese Industrial Standard has been revised by the Minister of Economy, Trade and Industry through deliberations at the Japanese Industrial Standards Committee as the result of proposal for revision of Japanese Industrial Standard submitted by Japan Mining Industry Association (JMIA)/Japanese Standards Association (JSA) with a draft being attached, based on the provision of Article 12, paragraph (1) of the Industrial Standardization Act applied mutatis mutandis pursuant to the provision of Article 16 of the said Act. This edition replaces the previous edition (JIS H 1163: 1991), which has been technically revised.

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Method for photoelectric emission spectrochemical analysis of cadmium metal

JIS H 1163: 2024

1 Scope

This Japanese Industrial Standard specifies the method for photoelectric emission spectrochemical analysis of cadmium metal specified in **JIS H 2113**.

This Standard applies to the determination of each element given in Table 1.

Table 1 Elements to be determined and dynamic range

Unit: % (mass fraction) Element to be Dynamic range determined Lead 0.000 5 or over up to and incl. 0.010 Copper 0.0001 or over up to and incl. 0.001 Zinc 0.000 5 or over up to and incl. 0.010 Iron 0.000 1 or over up to and incl. 0.001

2 Normative references

Part or all of the provisions of the following standards, through reference in this text, constitute provisions of this Standard. The most recent editions of the standards (including amendments) indicated below shall be applied.

JIS H 1161 Methods for chemical analysis of cadmium metal

JIS H 2113 Cadmium metal

JIS K 0116 General rules for atomic emission spectrometry

JIS K 0211 Technical terms for analytical chemistry (General part)

JIS K 0212 Technical terms for analytical chemistry (optical part)

JIS K 0215 Technical terms for analytical chemistry (Analytical instrument part)

JIS Z 8401 Rounding of numbers

JIS Z 8402-1 Accuracy (trueness and precision) of measurement methods and results — Part 1: General principles and definitions

3 Terms and definitions

For the purpose of this Standard, the following terms and definitions, and those giv-